

Product Change Notification / JAON-17JQJE576

Date:

18-Nov-2020

Product Category:

Ethernet PHYs

PCN Type:

Manufacturing Change

Notification Subject:

CCB 2519.001 Final Notice: Qualification of ANAC as an additional assembly site for selected LAN8710xx and LAN8720xx device families available in 32L VQFN (5x5x0.9mm) and 24L VQFN (4x4x0.9mm) packages.

Affected CPNs:

 $JAON-17JQJE576_Affected_CPN_11182020.pdf\\ JAON-17JQJE576_Affected_CPN_11182020.csv$

Notification Text:

PCN Status: Final notification

PCN Type: Manufacturing Change

Microchip Parts Affected: Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change: Qualification of ANAC as an additional assembly site for selected LAN8710xx and LAN8720xx device families available in 32L VQFN (5x5x0.9mm) and 24L VQFN (4x4x0.9mm) packages.

Pre Change:

Assembled at ASE using EN-4900F die attach and G631B mold compound material.

Post Change:

Assembled at ASE using EN-4900F die attach and G631B mold compound material or assembled at ANAC using 8290 die

attach and G700 mold compound material

Pre and Post Change Summary:

	Pre Change	Post Change				
Assembly Site	ASE Inc. (ASE)	ASE Inc. (ASE)	Amkor Assembly & Test (Shanghai) Co., LTD (ANAC)			
Wire material	PdCu	PdCu	PdCu			
Die attach material	EN-4900F	EN-4900F	8290			
Molding compound material	G631B	G631B	G700			
Lead frame material	C194	C194 C194				

Impacts to Data Sheet: None.

Change Impact:None.

Reason for Change: To improve on-time delivery performance by qualifying ANAC as an additional assembly site.

Change Implementation Status: In Progress

Estimated First Ship Date: December 20, 2020 (date code: 2052)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	November 2020			December 2020					
Workweek	45	46	47	48	49	50	51	52	53
Qual Report Availability			Х						
Final PCN Issue Date			Х						
Estimated First Ship Date								Х	

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:November 18, 2020: Issued final notification. Attached the qualification report. Provided estimated first ship date to be on December 20, 2020.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_JAON-17JQJE576_Qual_Report.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

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If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our PCN home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the PCN FAQ section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.



QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: JAON-17JQJE576

Date: August 18, 2016

Qualification of ANAC as an additional assembly site for selected products available in 36L VQFN (6x6x0.9mm) package. The qualification of ANAC as an additional assembly site for selected LAN8710xx and LAN8720xx device families available in 32L VQFN (5x5x0.9mm) and 24L VQFN (4x4x0.9mm) packages will qualify by similarity (QBS).



Purpose: Qualification of ANAC as an additional assembly site for selected products available in 36L VQFN (6x6x0.9mm) package. The qualification of ANAC as an additional assembly site for selected LAN8710xx and LAN8720xx device families available in 32L VQFN (5x5x0.9mm) and 24L VQFN (4x4x0.9mm) packages will qualify by similarity (QBS).

QUAL ID: QAR2016-009

CCB No.: 2519 and 2519.001

PRODUCT INFORMATION

PACKAGE TYPE	VQFN (PUNCH)
PACKAGE LEAD COUNT	36 (6x6x0.9mm)
TERMINAL PITCH	0.5mm
PACKAGE CODE	RPX
MATERIALS LISED IN ASSEMBLY	
I FADERAME PART NUMBER	101343095
	C194 (ETCHED)
LEADFRAME INTERNAL PLATING	DOUBLE RING
LEADFRAME SURFACE	NO TREATMENT
LEADFRAME PAD	3.90 x 3.90 mm
LEADFRAME SIZE	250 X 70mm (VHDLF)
LEADLOCK	NO
LEADFRAME THICKNESS	0.20mm
UNITS PER L/F STRIP	168 (24X7)
DIE ATTACH EPOXY TYPE	8290
EPOXY – CONDUCTIVE	YES
WIRE TYPE	PdCu
DOWNBOND	YES
MOLDING COMPOUND TYPE	G700
LEAD FINISH PROCESS	Matte Sn
MARKING	LASER



PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot (Test)	Wafer Lot	MARKING /Date Code
ANAC170300034.000	7MCM42406 000 wafer 24	USB2512B
	//////////////////////////////////////	D1615-A2P10
	/	615YKYA
	GF0/916422407.100	ATC-CN
	7NACN4240C 000 wefer 24	USB2512B
	/WICIWI42406.000 water 24	D1615-A2P10
ANAC170300035.000	/	615YM3A
	GF0/916422407.100	ATC-CN
	7NACM42406 000 wefer 24	USB2512B
ANAC170300036.000	/WICIVI42406.000 Water 24	D1615-A2P10
	/	615YM8A
	GF07910422407.100	ATC-CN

Result



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The 36L QFN (6x6X0.9mm) package using ALS Leadframe with PdCu wire, assembled by ANAC Pass Reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260°C reflow temperature per IPC/JEDEC J-STD-020D standard.

PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks	
Moisture/Reflow Sensitivity	30°C/ 60%RH	IPC/	240	0/240	Pass	LOT 1	
Classification Test	Moisture Soak 192 hrs.	JEDEC	240	0/240	Pass	LOT 2	
(At MSL Level 3)	(IPC/JEDEC J-STD-020D)	J-STD-020D	240	0/240	Pass	LOT 3	

Precondition Prior		JESD22-	240 (0)	240	PASS	Good
Perform Reliability	Electrical Test: +85°C	A113				Devices
Tests			Lot 1			
	SAT			240		
(At MSL Level 3)						
	Bake 125°C, 24hrs			240		
	85°C/85%RH Moisture Soak 192hrs			240		
				240		
	3x Convection-Reflow 260°C					
				240		
	SAT					
	Electrical Test : +85°C			240	PASS	

Precondition Prior		JESD22-	240 (0)	240	PASS	Good
Perform Reliability	Electrical Test: +85°C	A113				Devices
<u>Tests</u>			Lot 2			
(SAT			240		
(At MSL Level 3)						
	Bake 125°C, 24hrs			240		
	30°C/60%RH Moisture Soak 192hrs			240		
				240		
	3x Convection-Reflow 260°C					
				240		
	SAT					
	Electrical Test : +85°C			240	PASS	

Precondition Prior		JESD22-	240 (0)	240	PASS	Good
Perform Reliability	Electrical Test: +85°C	A113	1			Devices
<u>Tests</u>			LOT 3			
	SAT			240		
(At MSL Level 3)						
	Bake 125°C, 24hrs			240		
	30°C/60%RH Moisture Soak 192hrs			240		
				240		
	3x Convection-Reflow 260°C					
				240		
	SAT					
	Electrical Test : +85°C			240	PASS	

	PACKAGE QUALIFICATION REPORT							
Test Number	Test Condition	Standard/	Qty.	Def/SS.	Result	Remarks		
(Relefence)		Method	(ACC.)					
	Stress Condition: -	JESD22-A104		231		Parts had been pre-conditioned at		
	-65°C to +150°C, 1000x					260°C		
Temp Cycle	_				_			
	Electrical Test: +85°C		231 (0)	0/231	Pass	77 units / lot		
	Stress Condition: +130°C/85%RH, 192hrs	JESD22-A110		231		Parts had been pre-conditioned		
BHAST	Flectrical Test: +85°C		231 (0)			at 260°C		
				0/231	Pass	units / lot		
	Stress Condition: +130°C/85%RH_192brs	JESD22-A110		231		Parts had been		
uHAST						at 260°C		
	Electrical Test: +85°C		231 (0)	0/231	Pass	77 units / lot		
High Temperatu	Stress Condition: Bake +150°C,1008hrs	JESD22-A103		231		Parts had no pre-conditioned		
re Storage						•		
Life	Electrical Test : +85°C		231 (0)	0/231	Pass	77 units / lot		

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Affected Catalog Part Numbers (CPN)

LAN8720A-CP LAN8710A-EZC LAN8710A-EZK LAN8720AI-CP LAN8710AI-EZK LAN8720A-CP-TR LAN8710A-EZK-TR LAN8710A-EZC-TR LAN8720AI-CP-TR LAN8710AI-EZK-TR